

**Final datasheet**

**CoolSiC™ 1200 V SiC MOSFET G2 : Silicon Carbide MOSFET with .XT interconnection technology**

**Features**

- $V_{DSS} = 1200\text{ V}$  at  $T_{vj} = 25^\circ\text{C}$
- $I_{DC} = 27\text{ A}$  at  $T_C = 100^\circ\text{C}$
- $R_{DS(on)} = 53\text{ m}\Omega$  at  $V_{GS} = 18\text{ V}$ ,  $T_{vj} = 25^\circ\text{C}$
- Very low switching losses
- Overload operation up to  $T_{vj} = 200^\circ\text{C}$
- Short circuit withstand time  $2\ \mu\text{s}$
- Benchmark gate threshold voltage,  $V_{GS(th)} = 4.2\text{ V}$
- Robust against parasitic turn on, 0 V turn-off gate voltage can be applied
- Robust body diode for hard commutation
- .XT interconnection technology for best-in-class thermal performance
- Suitable Infineon gate drivers can be found under <https://www.infineon.com/gdfinder>



- Halogen-free
- Green
- Lead-free
- RoHS

**Potential applications**

- General purpose drives (GPD)
- EV Charging
- Online UPS/Industrial UPS
- Solar power optimizer
- String inverter
- Energy Storage Systems (ESS)
- Welding

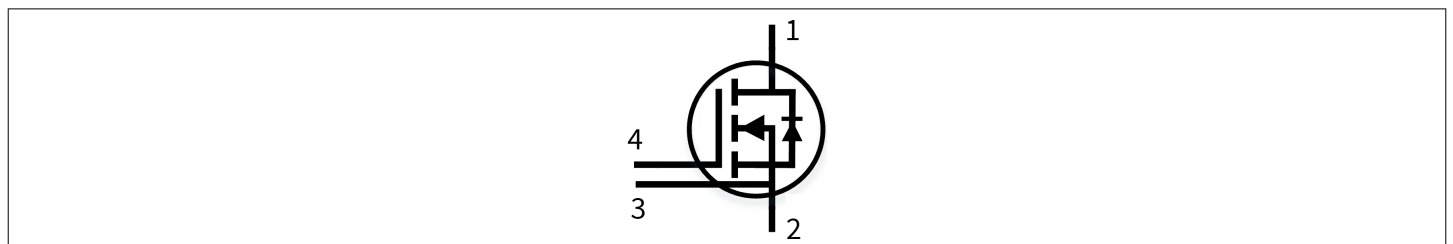
**Product validation**

- Qualified for industrial applications according to the relevant tests of JEDEC47/20/22

**Description**

- 1 – drain
- 2 – source
- 3 – Kelvin sense contact
- 4 – gate

Note: the source and sense pins are not exchangeable, their exchange might lead to malfunction



| Type           | Package        | Marking  |
|----------------|----------------|----------|
| IMZC120R053M2H | PG-TO247-4-U07 | 12M2H053 |

## Table of contents

|          |                                       |    |
|----------|---------------------------------------|----|
|          | <b>Description</b> .....              | 1  |
|          | <b>Features</b> .....                 | 1  |
|          | <b>Potential applications</b> .....   | 1  |
|          | <b>Product validation</b> .....       | 1  |
|          | <b>Table of contents</b> .....        | 2  |
| <b>1</b> | <b>Package</b> .....                  | 3  |
| <b>2</b> | <b>MOSFET</b> .....                   | 3  |
| <b>3</b> | <b>Body diode (MOSFET)</b> .....      | 6  |
| <b>4</b> | <b>Characteristics diagrams</b> ..... | 8  |
| <b>5</b> | <b>Package outlines</b> .....         | 14 |
| <b>6</b> | <b>Testing conditions</b> .....       | 15 |
|          | <b>Revision history</b> .....         | 16 |
|          | <b>Disclaimer</b> .....               | 17 |

## 1 Package

**Table 1** Characteristic values

| Parameter   | Symbol        | Note or test condition   | Values |      |      | Unit |
|---|---------------|--|--------|------|------|------|
|   |               |  | Min.   | Typ. | Max. |      |
| Storage temperature                                 | $T_{stg}$     |  | -55    |      | 150  | °C   |
| Soldering temperature                               | $T_{sold}$    | wave soldering only allowed at leads 1.6 mm (0.063 in.) from case for 10 s |        |      | 260  | °C   |
| Mounting torque                                     | $M$           | M3 screw, Maximum of mounting processes: 3                                 |        |      | 0.6  | Nm   |
| Thermal resistance, junction-ambient                | $R_{th(j-a)}$ |  |        |      | 62   | K/W  |
| MOSFET/body diode thermal resistance, junction-case | $R_{th(j-c)}$ |  |        | 0.63 | 0.82 | K/W  |

## 2 MOSFET

**Table 2** Maximum rated values

| Parameter  | Symbol    | Note or test condition  | Values                 | Unit          |   |
|--|-----------|---|------------------------|---------------|---|
| Drain-source voltage   | $V_{DSS}$ | $T_{vj} \geq 25 \text{ °C}$   | 1200                   | V             |   |
| Continuous DC drain current for $R_{th(j-c,max)}$ , limited by $T_{vj(max)}$ | $I_{DDC}$ | $V_{GS} = 18 \text{ V}$   | $T_c = 25 \text{ °C}$  | 38            | A |
|  |           |   | $T_c = 100 \text{ °C}$ | 27            |   |
| Peak drain current, $t_p$ limited by $T_{vj(max)}$ <sup>1)</sup>             | $I_{DM}$  | $V_{GS} = 18 \text{ V}$   | 81                     | A             |   |
| Gate-source voltage, max. transient voltage                                  | $V_{GS}$  | $t_p \leq 0.5 \text{ }\mu\text{s}$ , $D < 0.01$   | -10...25               | V             |   |
| Gate-source voltage, max. static voltage <sup>2)</sup>                       | $V_{GS}$  |   | -7...23                | V             |   |
| Avalanche energy, single pulse   | $E_{AS}$  | $I_D = 13 \text{ A}$ , $V_{DD} = 50 \text{ V}$ , $L = 1.9 \text{ mH}$ ,<br>$T_{vj(start)} = 25 \text{ °C}$                      | 166                    | mJ            |   |
| Avalanche energy, repetitive   | $E_{AR}$  | $I_D = 13 \text{ A}$ , $V_{DD} = 50 \text{ V}$ , $L = 9.5 \text{ }\mu\text{H}$ ,<br>$T_{vj(start)} = 25 \text{ °C}$             | 0.83                   | mJ            |   |
| Short-circuit withstand time   | $t_{SC}$  | $V_{DD} \leq 800 \text{ V}$ , $V_{DS,peak} < 1200 \text{ V}$ , $V_{GS(on)} = 15 \text{ V}$ ,<br>$T_{vj(start)} = 25 \text{ °C}$ | 2                      | $\mu\text{s}$ |   |
| Power dissipation, limited by $T_{vj(max)}$                                  | $P_{tot}$ |   | $T_c = 25 \text{ °C}$  | 182           | W |
|  |           |   | $T_c = 100 \text{ °C}$ | 91            |   |

1) Verified by design.

2) The maximum gate-source voltage in the application design should be in accordance to IPC-9592B.

**Table 3 Recommended values**

| Parameter                         | Symbol        | Note or test condition | Values  | Unit |
|-----------------------------------|---------------|------------------------|---------|------|
| Recommended turn-on gate voltage  | $V_{GS(on)}$  |                        | 15...18 | V    |
| Recommended turn-off gate voltage | $V_{GS(off)}$ |                        | -5...0  | V    |

**Table 4 Characteristic values**

| Parameter                                    | Symbol       | Note or test condition   | Values   |      |      | Unit |    |
|--|--------------|--|--|------|------|------|----|
|  |              |  | Min.   | Typ. | Max. |      |    |
| Drain-source on-state resistance             | $R_{DS(on)}$ | $I_D = 13\text{ A}$  | $T_{vj} = 25\text{ °C}$ ,<br>$V_{GS(on)} = 18\text{ V}$  |      | 53   |      | mΩ |
|  |              |  | $T_{vj} = 150\text{ °C}$ ,<br>$V_{GS(on)} = 18\text{ V}$ |      | 107  | 137  |    |
|  |              |  | $T_{vj} = 175\text{ °C}$ ,<br>$V_{GS(on)} = 18\text{ V}$ |      | 124  |      |    |
|  |              |  | $T_{vj} = 25\text{ °C}$ ,<br>$V_{GS(on)} = 15\text{ V}$  |      | 66   |      |    |
| Gate-source threshold voltage                | $V_{GS(th)}$ | $I_D = 4.1\text{ mA}$ , $V_{DS} = V_{GS}$<br>(tested after 1 ms pulse at $V_{GS} = 20\text{ V}$ )  | $T_{vj} = 25\text{ °C}$                                  | 3.5  | 4.2  | 5.1  | V  |
|  |              |  | $T_{vj} = 175\text{ °C}$                                 |      | 3.2  |      |    |
| Zero gate-voltage drain current              | $I_{DSS}$    | $V_{DS} = 1200\text{ V}$ , $V_{GS} = 0\text{ V}$   | $T_{vj} = 25\text{ °C}$                                  |      |      | 110  | μA |
|  |              |  | $T_{vj} = 175\text{ °C}$                                 |      | 2    |      |    |
| Gate leakage current                         | $I_{GSS}$    | $V_{DS} = 0\text{ V}$  | $V_{GS} = 23\text{ V}$                                   |      |      | 120  | nA |
|  |              |  | $V_{GS} = -10\text{ V}$                                  |      |      | -120 |    |
| Forward transconductance                     | $g_{fs}$     | $I_D = 13\text{ A}$ , $V_{DS} = 20\text{ V}$   |  | 9    |      | S    |    |
| Internal gate resistance                     | $R_{G,int}$  | $f = 1\text{ MHz}$ , $V_{AC} = 25\text{ mV}$   |  | 8.5  |      | Ω    |    |
| Input capacitance                            | $C_{iss}$    | $V_{DD} = 800\text{ V}$ , $V_{GS} = 0\text{ V}$ , $f = 100\text{ kHz}$ , $V_{AC} = 25\text{ mV}$   |  | 1010 |      | pF   |    |
| Output capacitance                           | $C_{oss}$    | $V_{DD} = 800\text{ V}$ , $V_{GS} = 0\text{ V}$ , $f = 100\text{ kHz}$ , $V_{AC} = 25\text{ mV}$   |  | 41   |      | pF   |    |
| Reverse transfer capacitance                 | $C_{rss}$    | $V_{DD} = 800\text{ V}$ , $V_{GS} = 0\text{ V}$ , $f = 100\text{ kHz}$ , $V_{AC} = 25\text{ mV}$   |  | 4    |      | pF   |    |
| $C_{oss}$ stored energy                      | $E_{oss}$    | $V_{DD} = 800\text{ V}$ , $V_{GS} = 0\text{ V}$ , $f = 100\text{ kHz}$ , $V_{AC} = 25\text{ mV}$   |  | 17   |      | μJ   |    |
| Output charge                                | $Q_{oss}$    | $V_{DD} = 800\text{ V}$ , $V_{GS} = 0\text{ V}$ , $f = 100\text{ kHz}$ ,<br>$V_{AC} = 25\text{ mV}$ , Calculated by $C_{oss} * f(V_{DS}) @ 100\text{ kHz}$ |  | 64   |      | nC   |    |
| Effective output capacitance, energy related | $C_{o(er)}$  | $V_{DD} = 0...800\text{ V}$ , $V_{GS} = 0\text{ V}$  |  | 53   |      | pF   |    |
| Effective output capacitance, time related   | $C_{o(tr)}$  | $I_D = \text{constant}$ , $V_{DD} = 0...800\text{ V}$ , $V_{GS} = 0\text{ V}$  |  | 80   |      | pF   |    |

**(table continues...)**

**Table 4 (continued) Characteristic values**

| Parameter            | Symbol       | Note or test condition   | Values                               |      |      | Unit          |
|----------------------|--------------|--|--------------------------------------|------|------|---------------|
|                      |              |  | Min.                                 | Typ. | Max. |               |
| Total gate charge    | $Q_G$        | $V_{DD} = 800\text{ V}$ , $I_D = 13\text{ A}$ , $V_{GS} = 0/18\text{ V}$ , turn-on pulse   |                                      | 30   |      | nC            |
| Plateau gate charge  | $Q_{GS(pl)}$ | $V_{DD} = 800\text{ V}$ , $I_D = 13\text{ A}$ , $V_{GS} = 0/18\text{ V}$ , turn-on pulse   |                                      | 7    |      | nC            |
| Gate-to-drain charge | $Q_{GD}$     | $V_{DD} = 800\text{ V}$ , $I_D = 13\text{ A}$ , $V_{GS} = 0/18\text{ V}$ , turn-on pulse   |                                      | 8    |      | nC            |
| Turn-on delay time   | $t_{d(on)}$  | $V_{DD} = 800\text{ V}$ , $I_D = 13\text{ A}$ ,<br>$V_{GS} = 0/18\text{ V}$ ,<br>$R_{GS(on)} = 2.3\ \Omega$ ,<br>$R_{GS(off)} = 2.3\ \Omega$ ,<br>$L_\sigma = 18\text{ nH}$ , diode: body diode at $V_{GS} = 0\text{ V}$ | $T_{vj} = 25\text{ }^\circ\text{C}$  | 4.5  |      | ns            |
|                      |              |  | $T_{vj} = 175\text{ }^\circ\text{C}$ | 4.1  |      |               |
| Rise time            | $t_r$        | $V_{DD} = 800\text{ V}$ , $I_D = 13\text{ A}$ ,<br>$V_{GS} = 0/18\text{ V}$ ,<br>$R_{GS(on)} = 2.3\ \Omega$ ,<br>$R_{GS(off)} = 2.3\ \Omega$ ,<br>$L_\sigma = 18\text{ nH}$ , diode: body diode at $V_{GS} = 0\text{ V}$ | $T_{vj} = 25\text{ }^\circ\text{C}$  | 5.5  |      | ns            |
|                      |              |  | $T_{vj} = 175\text{ }^\circ\text{C}$ | 5.2  |      |               |
| Turn-off delay time  | $t_{d(off)}$ | $V_{DD} = 800\text{ V}$ , $I_D = 13\text{ A}$ ,<br>$V_{GS} = 0/18\text{ V}$ ,<br>$R_{GS(on)} = 2.3\ \Omega$ ,<br>$R_{GS(off)} = 2.3\ \Omega$ ,<br>$L_\sigma = 18\text{ nH}$ , diode: body diode at $V_{GS} = 0\text{ V}$ | $T_{vj} = 25\text{ }^\circ\text{C}$  | 10   |      | ns            |
|                      |              |  | $T_{vj} = 175\text{ }^\circ\text{C}$ | 17.4 |      |               |
| Fall time            | $t_f$        | $V_{DD} = 800\text{ V}$ , $I_D = 13\text{ A}$ ,<br>$V_{GS} = 0/18\text{ V}$ ,<br>$R_{GS(on)} = 2.3\ \Omega$ ,<br>$R_{GS(off)} = 2.3\ \Omega$ ,<br>$L_\sigma = 18\text{ nH}$ , diode: body diode at $V_{GS} = 0\text{ V}$ | $T_{vj} = 25\text{ }^\circ\text{C}$  | 5.9  |      | ns            |
|                      |              |  | $T_{vj} = 175\text{ }^\circ\text{C}$ | 6.9  |      |               |
| Turn-on energy       | $E_{on}$     | $V_{DD} = 800\text{ V}$ , $I_D = 13\text{ A}$ ,<br>$V_{GS} = 0/18\text{ V}$ ,<br>$R_{GS(on)} = 2.3\ \Omega$ ,<br>$R_{GS(off)} = 2.3\ \Omega$ ,<br>$L_\sigma = 18\text{ nH}$ , diode: body diode at $V_{GS} = 0\text{ V}$ | $T_{vj} = 25\text{ }^\circ\text{C}$  | 95   |      | $\mu\text{J}$ |
|                      |              |  | $T_{vj} = 175\text{ }^\circ\text{C}$ | 197  |      |               |
| Turn-off energy      | $E_{off}$    | $V_{DD} = 800\text{ V}$ , $I_D = 13\text{ A}$ ,<br>$V_{GS} = 0/18\text{ V}$ ,<br>$R_{GS(on)} = 2.3\ \Omega$ ,<br>$R_{GS(off)} = 2.3\ \Omega$ ,<br>$L_\sigma = 18\text{ nH}$ , diode: body diode at $V_{GS} = 0\text{ V}$ | $T_{vj} = 25\text{ }^\circ\text{C}$  | 30   |      | $\mu\text{J}$ |
|                      |              |  | $T_{vj} = 175\text{ }^\circ\text{C}$ | 49   |      |               |

**(table continues...)**

3 Body diode (MOSFET)

**Table 4** (continued) Characteristic values

| Parameter                            | Symbol         | Note or test condition   | Values                               |      |      | Unit             |
|--------------------------------------|----------------|--|--------------------------------------|------|------|------------------|
|                                      |                |  | Min.                                 | Typ. | Max. |                  |
| Total switching energy <sup>1)</sup> | $E_{tot}$      | $V_{DD} = 800\text{ V}$ , $I_D = 13\text{ A}$ ,<br>$V_{GS} = 0/18\text{ V}$ ,<br>$R_{GS(on)} = 2.3\ \Omega$ ,<br>$R_{GS(off)} = 2.3\ \Omega$ ,<br>$L_\sigma = 18\text{ nH}$ , diode: body diode at $V_{GS} = 0\text{ V}$ | $T_{vj} = 25\text{ }^\circ\text{C}$  | 174  |      | $\mu\text{J}$    |
|                                      |                |  | $T_{vj} = 175\text{ }^\circ\text{C}$ | 370  |      |                  |
| Virtual junction temperature         | $T_{vj}$       |  | -55                                  |      | 175  | $^\circ\text{C}$ |
| Virtual junction temperature         | $T_{vj(over)}$ | overload, cumulative max. 100 h <sup>2)</sup>  |                                      |      | 200  | $^\circ\text{C}$ |

1) including  $E_{fr}$

2) up to 5000 cycles. Maximum  $\Delta T$  limited to 100 K.

**Note:** The chip technology was characterized up to 200 kV/ $\mu\text{s}$ . The measured  $dV/dt$  was limited by measurement test setup and package.

Characteristics at  $T_{vj} = 25\text{ }^\circ\text{C}$ , unless otherwise specified.

### 3 Body diode (MOSFET)

**Table 5** Maximum rated values

| Parameter  | Symbol    | Note or test condition                 | Values | Unit |
|--|-----------|--|--------|------|
| Drain-source voltage                                       | $V_{DSS}$ | $T_{vj} \geq 25\text{ }^\circ\text{C}$ | 1200   | V    |
| Peak reverse drain current, $t_p$ limited by $T_{vj(max)}$ | $I_{SM}$  | $V_{GS} = 0\text{ V}$                  | 81     | A    |

**Table 6** Characteristic values

| Parameter                            | Symbol    | Note or test condition   | Values                               |      |      | Unit          |
|--------------------------------------|-----------|--|--------------------------------------|------|------|---------------|
|                                      |           |  | Min.                                 | Typ. | Max. |               |
| Drain-source reverse voltage         | $V_{SD}$  | $I_{SD} = 13\text{ A}$ , $V_{GS} = 0\text{ V}$   | $T_{vj} = 25\text{ }^\circ\text{C}$  | 4.2  | 5.5  | V             |
|                                      |           |  | $T_{vj} = 100\text{ }^\circ\text{C}$ | 4.11 |      |               |
|                                      |           |  | $T_{vj} = 175\text{ }^\circ\text{C}$ | 4.05 |      |               |
| MOSFET forward recovery charge       | $Q_{fr}$  | $V_{DD} = 800\text{ V}$ , $I_{SD} = 13\text{ A}$ ,<br>$V_{GS} = 0\text{ V}$ , $R_{GS(on)} = 2.3\ \Omega$ ,<br>$Q_{fr}$ includes also $Q_C$ | $T_{vj} = 25\text{ }^\circ\text{C}$  | 0.19 |      | $\mu\text{C}$ |
|                                      |           |  | $T_{vj} = 175\text{ }^\circ\text{C}$ | 0.4  |      |               |
| MOSFET peak forward recovery current | $I_{frm}$ | $V_{DD} = 800\text{ V}$ , $I_{SD} = 13\text{ A}$ ,<br>$V_{GS} = 0\text{ V}$ , $R_{GS(on)} = 2.3\ \Omega$ ,<br>$Q_{fr}$ includes also $Q_C$ | $T_{vj} = 25\text{ }^\circ\text{C}$  | 14.3 |      | A             |
|                                      |           |  | $T_{vj} = 175\text{ }^\circ\text{C}$ | 28.5 |      |               |

(table continues...)

**Table 6** (continued) **Characteristic values**

| Parameter                      | Symbol         | Note or test condition   | Values                    |      |      | Unit               |
|--------------------------------|----------------|--|---------------------------|------|------|--------------------|
|                                |                |  | Min.                      | Typ. | Max. |                    |
| MOSFET forward recovery energy | $E_{fr}$       | $V_{DD} = 800 \text{ V}$ , $I_{SD} = 13 \text{ A}$ ,<br>$V_{GS} = 0 \text{ V}$ , $R_{GS(on)} = 2.3 \Omega$ ,<br>$Q_{fr}$ includes also $Q_C$ | $T_{vj} = 25 \text{ °C}$  | 49   |      | $\mu\text{J}$      |
|                                |                |  | $T_{vj} = 175 \text{ °C}$ | 124  |      |                    |
| Virtual junction temperature   | $T_{vj}$       |  | -55                       |      | 175  | $^{\circ}\text{C}$ |
| Virtual junction temperature   | $T_{vj(over)}$ | overload, cumulative max. 100 h <sup>1)</sup>  |                           |      | 200  | $^{\circ}\text{C}$ |

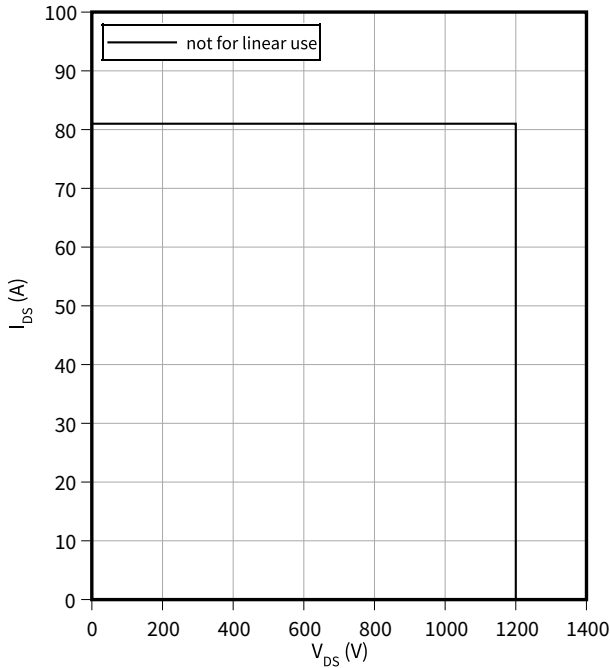
1) up to 5000 cycles. Maximum  $\Delta T$  limited to 100 K.

## 4 Characteristics diagrams

### Reverse bias safe operating area (RBSOA)

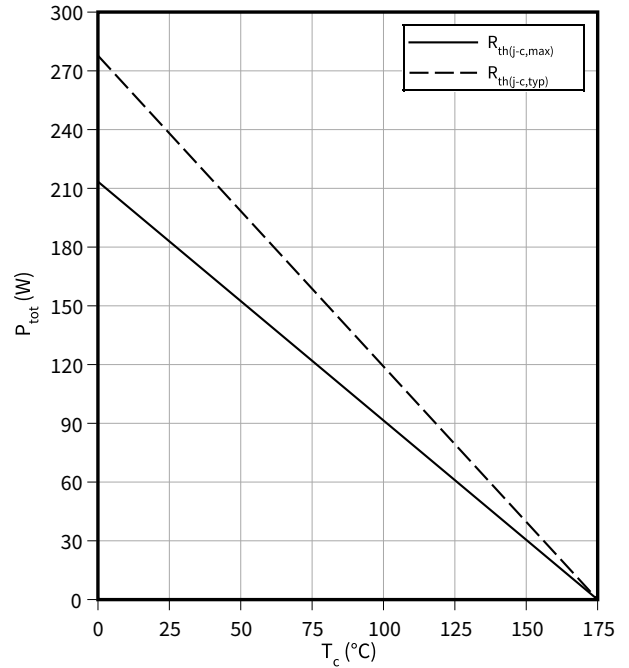
$$I_{DS} = f(V_{DS})$$

$$V_{GS} = 0/18 \text{ V}, T_{vj} \leq 200 \text{ }^\circ\text{C}, T_c = 25 \text{ }^\circ\text{C}$$



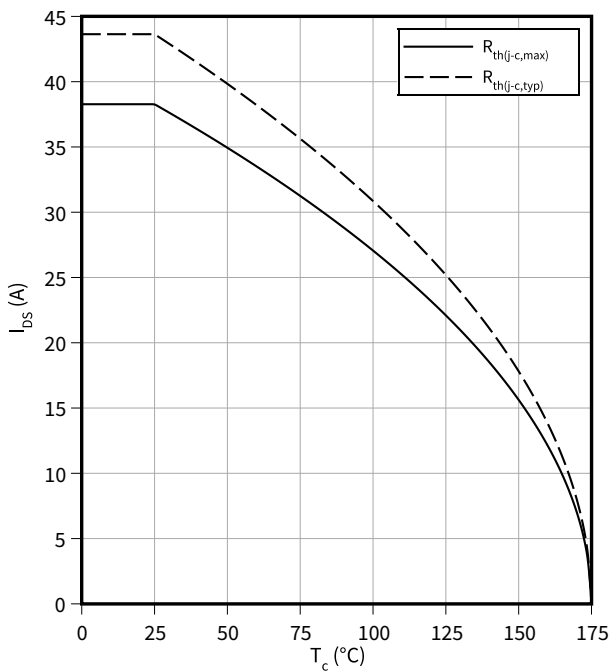
### Power dissipation as a function of case temperature

$$P_{tot} = f(T_c)$$



### Maximum DC drain to source current as a function of case temperature limited by bond wire

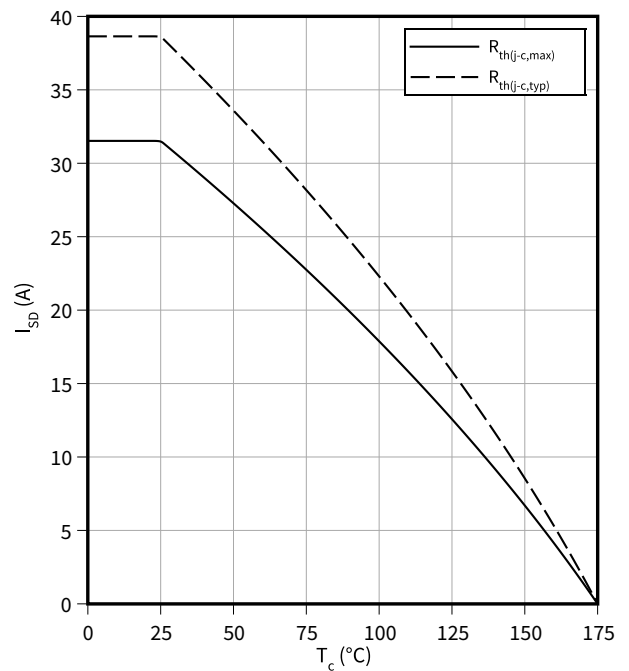
$$I_{DS} = f(T_c)$$



### Maximum source to drain current as a function of case temperature limited by bond wire

$$I_{SD} = f(T_c)$$

$$V_{GS} = 0 \text{ V}$$

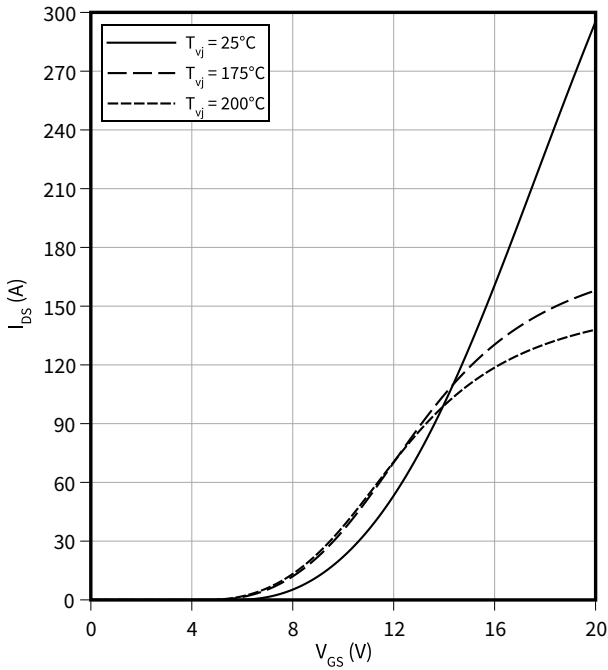




4 Characteristics diagrams

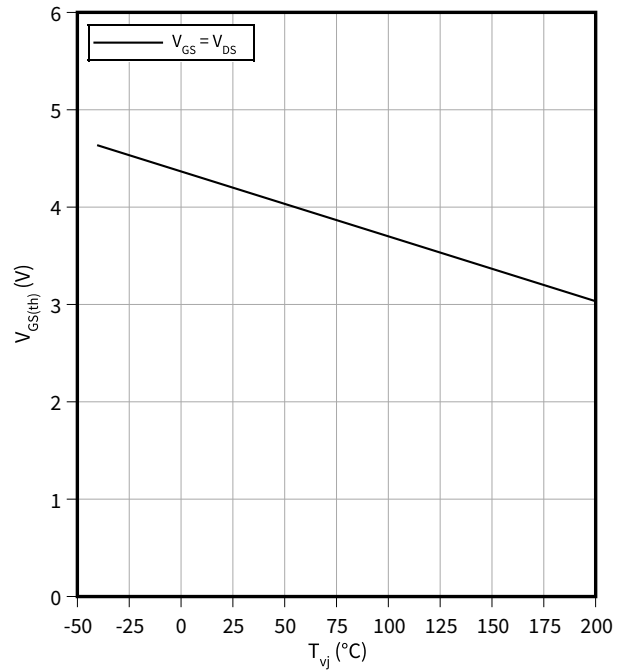
**Typical transfer characteristic**

$I_{DS} = f(V_{GS})$   
 $V_{DS} = 20 \text{ V}$ ,  $t_p = 20 \mu\text{s}$



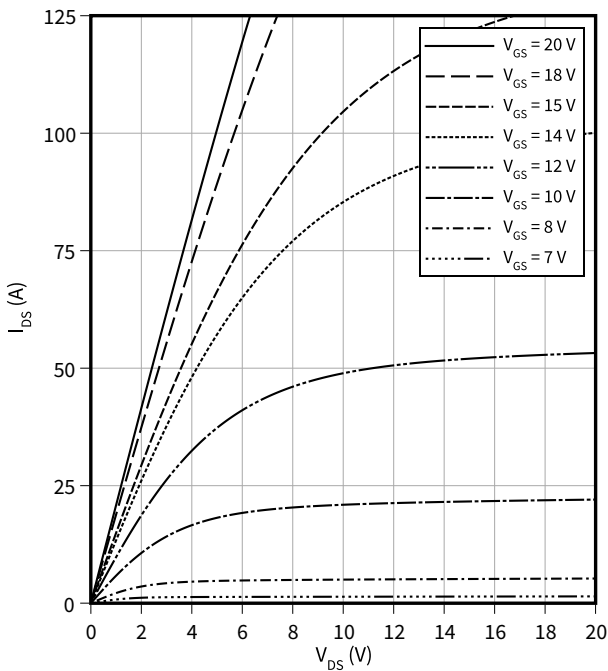
**Typical gate-source threshold voltage as a function of junction temperature**

$V_{GS(th)} = f(T_{vj})$   
 $I_D = 4.1 \text{ mA}$



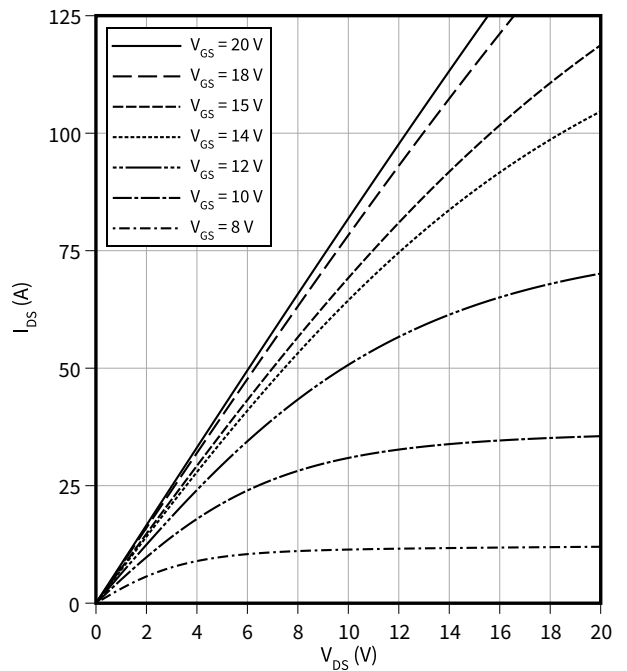
**Typical output characteristic,  $V_{GS}$  as parameter**

$I_{DS} = f(V_{DS})$   
 $T_{vj} = 25^\circ\text{C}$ ,  $t_p = 20 \mu\text{s}$



**Typical output characteristic,  $V_{GS}$  as parameter**

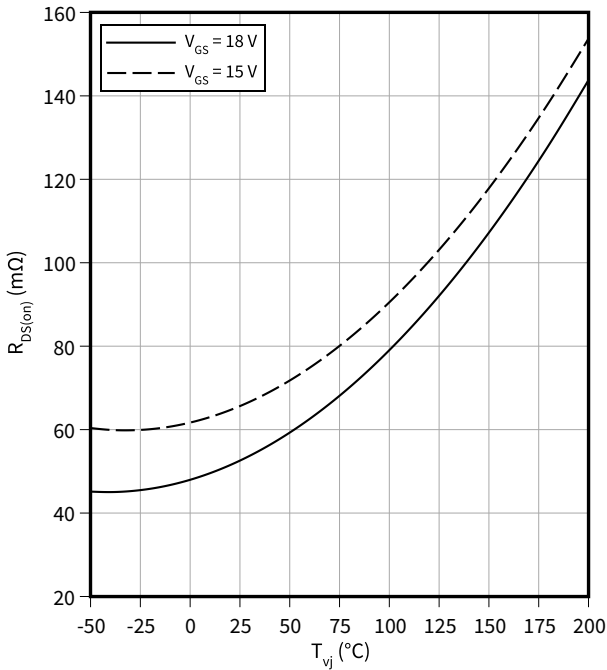
$I_{DS} = f(V_{DS})$   
 $T_{vj} = 175^\circ\text{C}$ ,  $t_p = 20 \mu\text{s}$



4 Characteristics diagrams

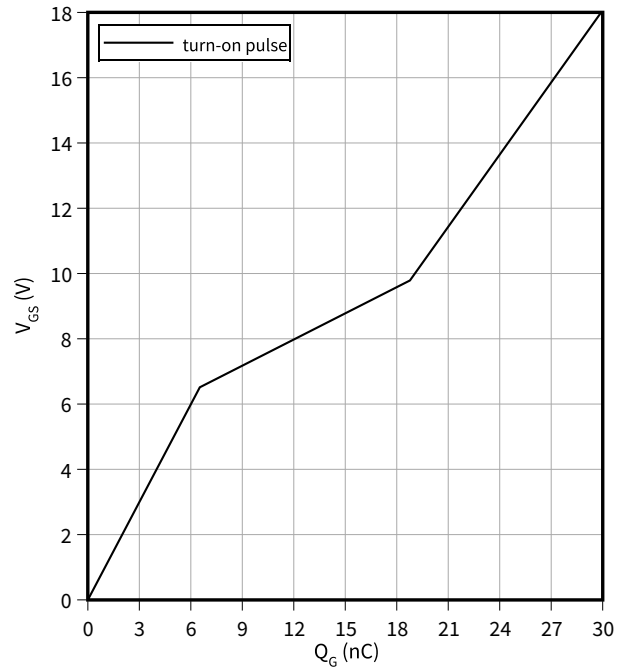
**Typical on-state resistance as a function of junction temperature**

$R_{DS(on)} = f(T_{vj})$   
 $I_D = 13 \text{ A}$



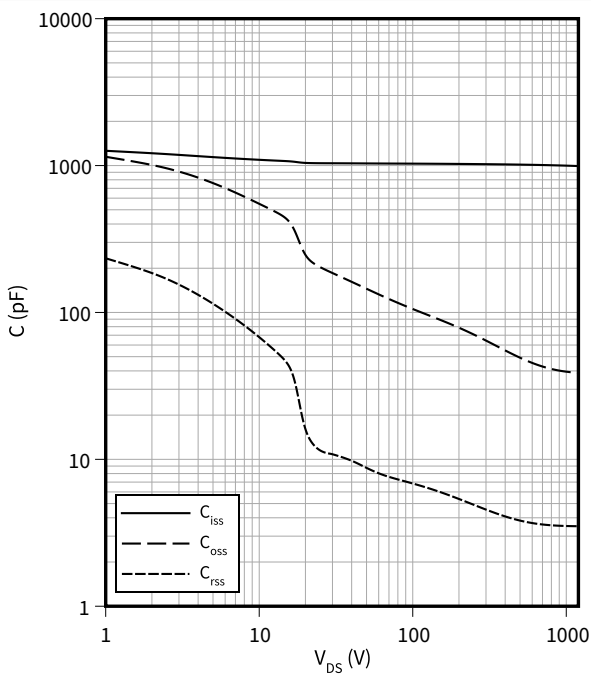
**Typical gate charge**

$V_{GS} = f(Q_G)$   
 $I_D = 13 \text{ A}, V_{DS} = 800 \text{ V}$



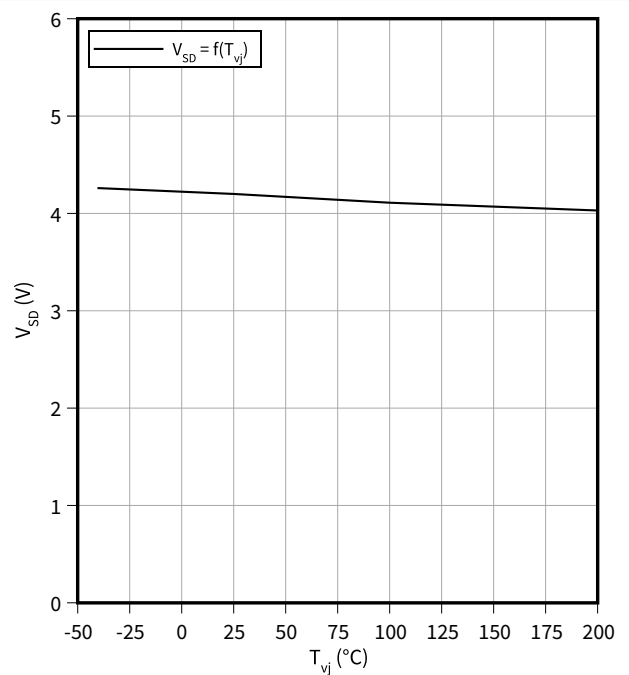
**Typical capacitance as a function of drain-source voltage**

$C = f(V_{DS})$   
 $f = 100 \text{ kHz}, V_{GS} = 0 \text{ V}$



**Typical reverse drain voltage as function of junction temperature**

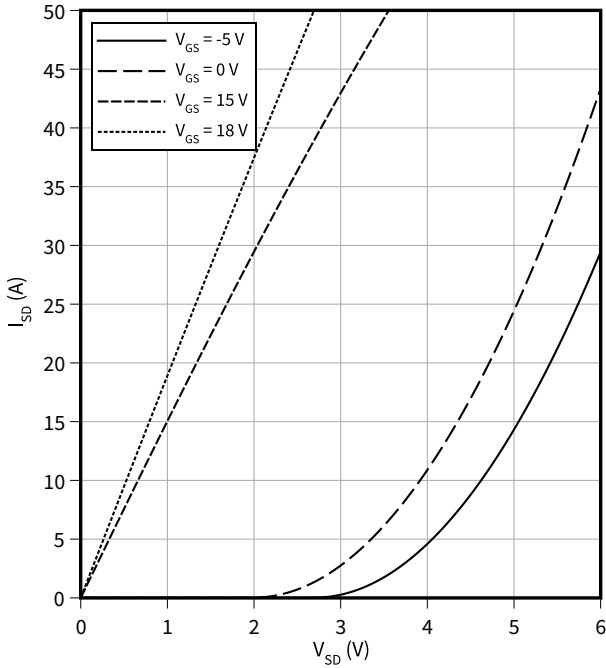
$V_{SD} = f(T_{vj})$   
 $I_{SD} = 13 \text{ A}, V_{GS} = 0 \text{ V}$



4 Characteristics diagrams

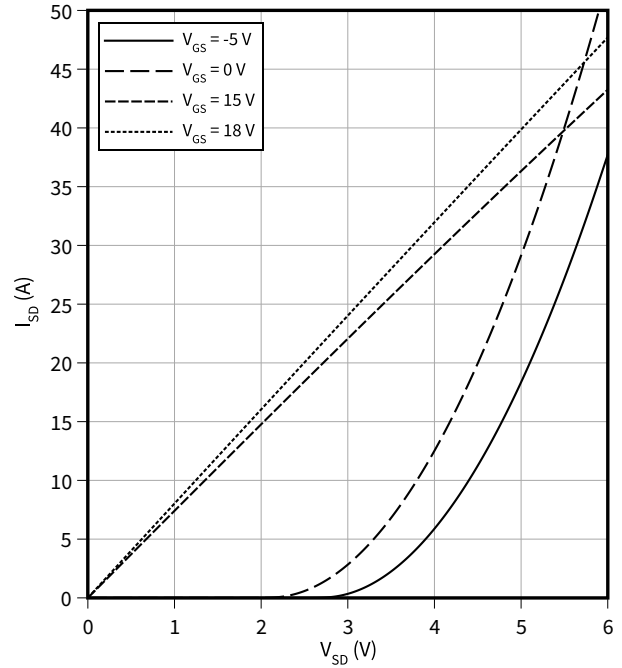
**Typical reverse drain current as function of reverse drain voltage,  $V_{GS}$  as parameter**

$I_{SD} = f(V_{SD})$   
 $T_{vj} = 25\text{ °C}$ ,  $t_p = 20\text{ }\mu\text{s}$



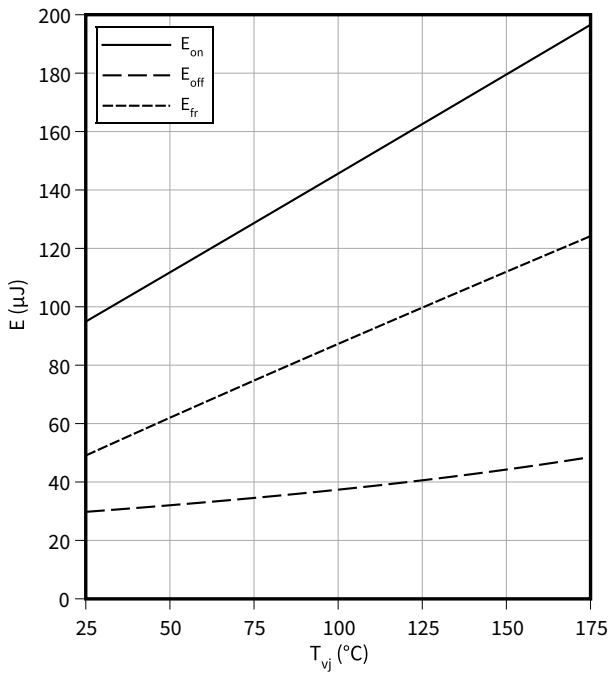
**Typical reverse drain current as function of reverse drain voltage,  $V_{GS}$  as parameter**

$I_{SD} = f(V_{SD})$   
 $T_{vj} = 175\text{ °C}$ ,  $t_p = 20\text{ }\mu\text{s}$



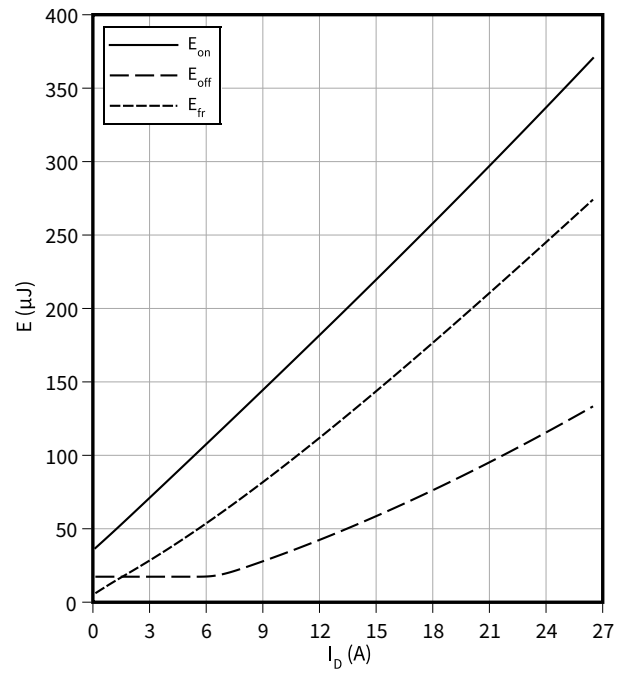
**Typical switching energy as a function of junction temperature, test circuit in Fig. F, 2nd device own body diode:  $V_{GS} = 0\text{ V}$**

$E = f(T_{vj})$   
 $V_{GS} = 0/18\text{ V}$ ,  $I_D = 13\text{ A}$ ,  $R_{G,ext} = 2.3\text{ }\Omega$ ,  $V_{DD} = 800\text{ V}$



**Typical switching energy as a function of drain current, test circuit in Fig. F, 2nd device own body diode:  $V_{GS} = 0\text{ V}$**

$E = f(I_D)$   
 $V_{GS} = 0/18\text{ V}$ ,  $T_{vj} = 175\text{ °C}$ ,  $R_{G,ext} = 2.3\text{ }\Omega$ ,  $V_{DD} = 800\text{ V}$

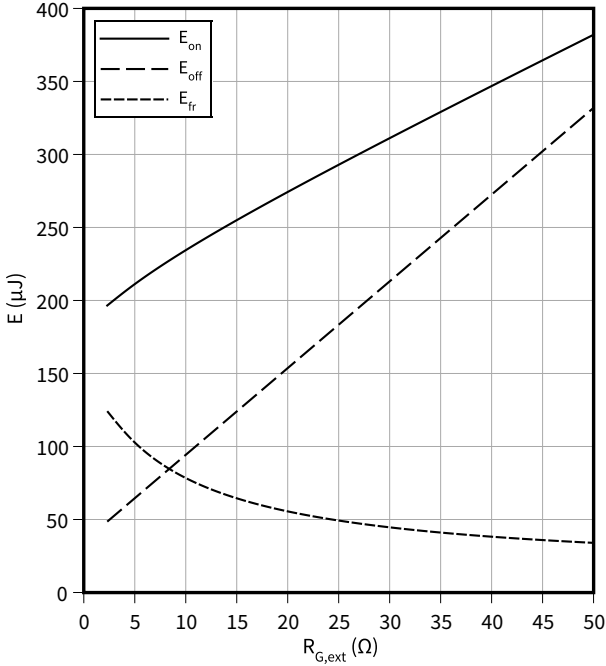


4 Characteristics diagrams

**Typical switching energy as a function of gate resistance, test circuit in Fig. F, 2nd device own body diode:  $V_{GS} = 0\text{ V}$**

$E = f(R_{G,ext})$

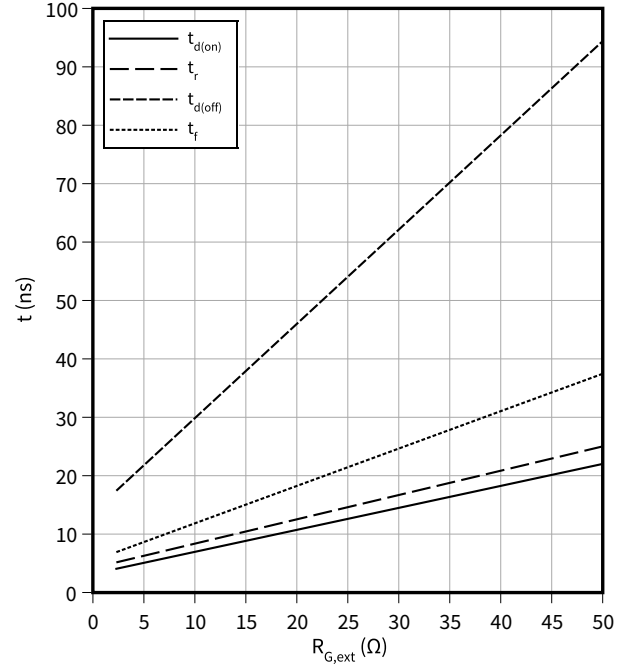
$V_{GS} = 0/18\text{ V}$ ,  $I_D = 13\text{ A}$ ,  $T_{vj} = 175\text{ °C}$ ,  $V_{DD} = 800\text{ V}$



**Typical switching times as a function of gate resistance, test circuit in Fig. F, 2nd device own body diode:  $V_{GS} = -0\text{ V}$**

$t = f(R_{G,ext})$

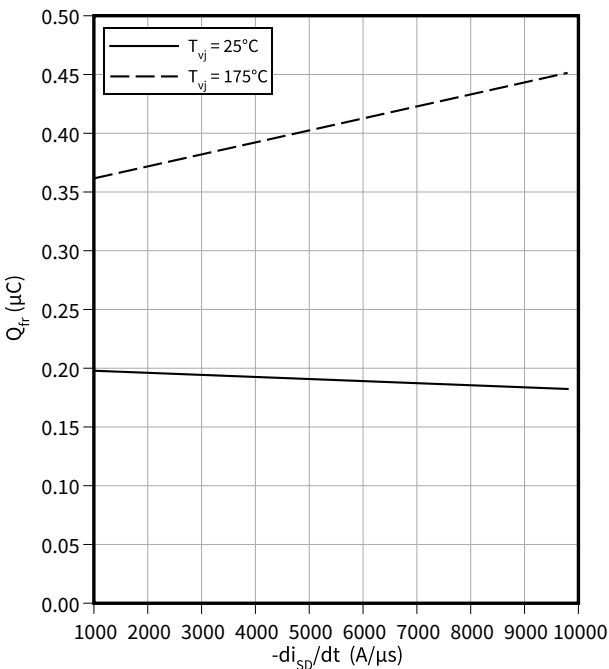
$V_{GS} = 0/18\text{ V}$ ,  $I_D = 13\text{ A}$ ,  $T_{vj} = 175\text{ °C}$ ,  $V_{DD} = 800\text{ V}$



**Typical reverse recovery charge as a function of reverse drain current slope, test circuit in Fig. F, 2nd device own body diode:  $V_{GS} = 0\text{ V}$**

$Q_{fr} = f(-di_{SD}/dt)$

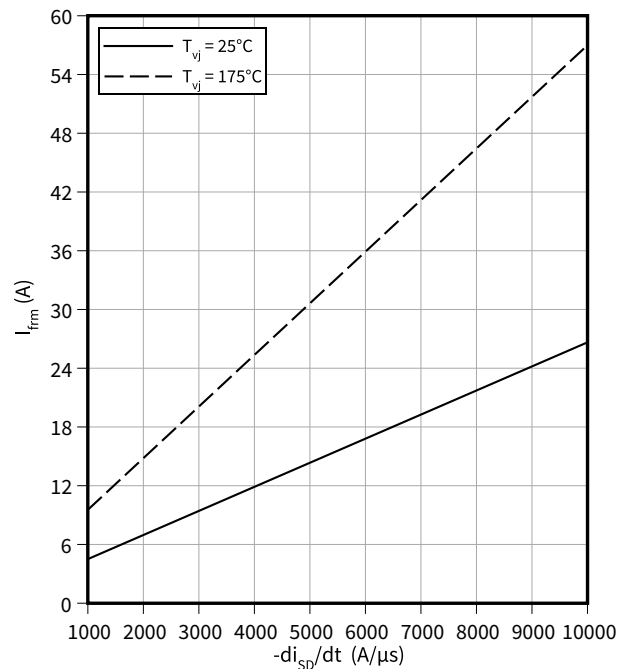
$V_{GS} = 0/18\text{ V}$ ,  $I_{SD} = 13\text{ A}$ ,  $V_{DD} = 800\text{ V}$



**Typical reverse recovery current as a function of reverse drain current slope, test circuit in Fig. F, 2nd device own body diode:  $V_{GS} = 0\text{ V}$**

$I_{frm} = f(-di_{SD}/dt)$

$V_{GS} = 0/18\text{ V}$ ,  $I_{SD} = 13\text{ A}$ ,  $V_{DD} = 800\text{ V}$



4 Characteristics diagrams

**Typical switching energy as a function of dead time / blanking time, test circuit in Fig. F, 2nd device own body diode:  $V_{GS} = 0\text{ V}$**

$$E = f(t_{\text{dead}})$$

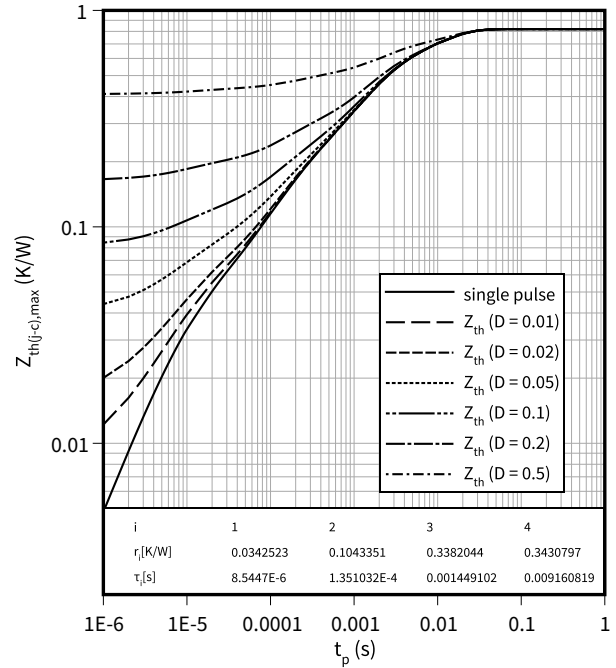
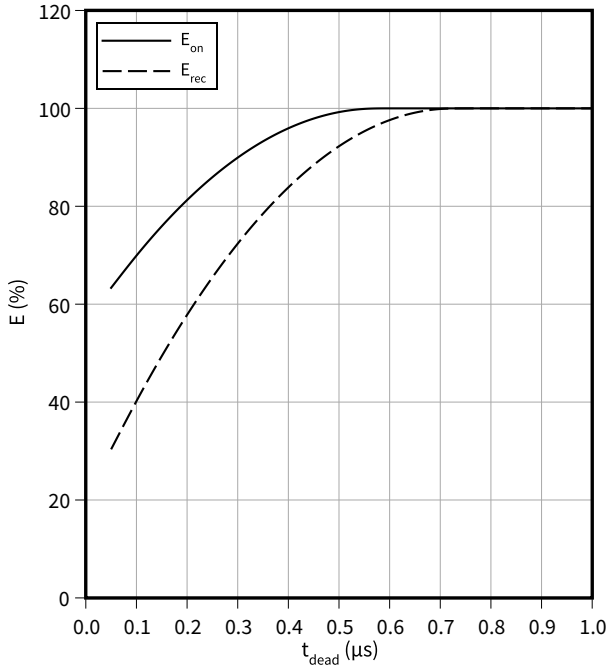
$I_D = 13\text{ A}$ ,  $V_{GS} = 0/18\text{ V}$ ,  $T_{vj} = 175\text{ °C}$ ,  $R_{G,\text{ext}} = 2.3\ \Omega$

$V_{DD} = 800\text{ V}$

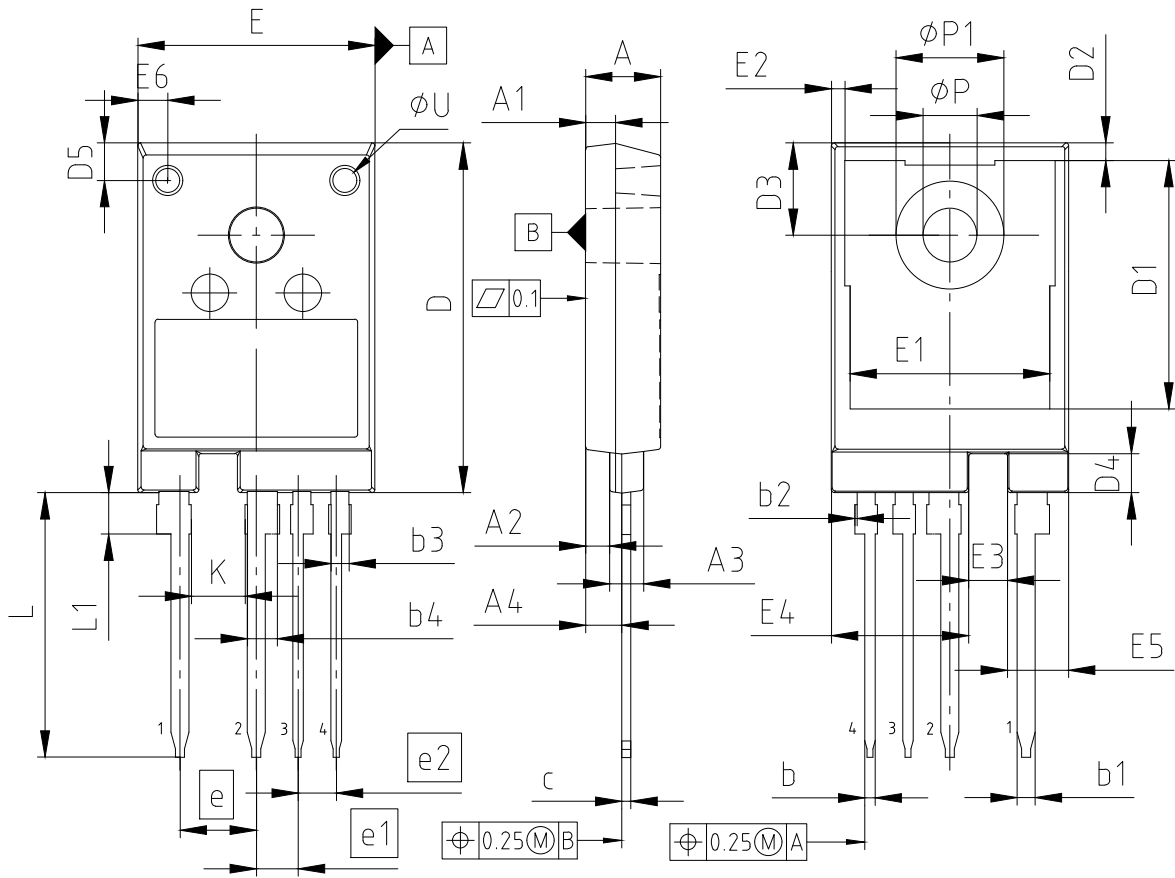
**Max. transient thermal impedance (MOSFET/diode)**

$$Z_{\text{th}(j-c),\text{max}} = f(t_p)$$

$$D = t_p/T$$



## 5 Package outlines



PACKAGE - GROUP NUMBER: **PG-T0247-4-U07**

| DIMENSIONS | MILLIMETERS |       | DIMENSIONS | MILLIMETERS |       |
|------------|-------------|-------|------------|-------------|-------|
|            | MIN.        | MAX.  |            | MIN.        | MAX.  |
| <b>A</b>   | 4.90        | 5.10  | <b>E</b>   | 15.60       | 16.00 |
| <b>A1</b>  | 1.90        | 2.10  | <b>E1</b>  | 13.10       | 13.50 |
| <b>A2</b>  | 1.50        | 1.70  | <b>E2</b>  | 0.60        | 1.20  |
| <b>A3</b>  | 2.16        | 2.36  | <b>E3</b>  | 2.48        | 2.68  |
| <b>A4</b>  | 2.31        | 2.51  | <b>E4</b>  | 9.05        | 9.25  |
| <b>b</b>   | 0.60        | 0.80  | <b>E5</b>  | 3.97        | 4.17  |
| <b>b1</b>  | 1.10        | 1.30  | <b>E6</b>  | 1.80        | 2.20  |
| <b>b2</b>  | ---         | 0.15  | <b>e</b>   | 5.08        |       |
| <b>b3</b>  | 1.10        | 1.30  | <b>e1</b>  | 2.79        |       |
| <b>b4</b>  | 1.90        | 2.10  | <b>e2</b>  | 2.54        |       |
| <b>c</b>   | 0.50        | 0.70  | <b>K</b>   | 3.50        | ---   |
| <b>D</b>   | 23.10       | 23.50 | <b>L</b>   | 17.50       | 17.80 |
| <b>D1</b>  | 16.25       | 16.85 | <b>L1</b>  | 2.61        | 2.91  |
| <b>D2</b>  | 0.97        | 1.37  | <b>N</b>   | 4           |       |
| <b>D3</b>  | 6.00        | 6.30  | <b>ØP1</b> | 7.00        | 7.40  |
| <b>D4</b>  | 2.50        | 2.70  | <b>ØP</b>  | 3.50        | 3.70  |
| <b>D5</b>  | 2.30        | 2.70  | <b>ØU</b>  | 1.40        | 1.80  |

NOTES: DIMENSIONS DO NOT INCLUDE MOLD FLASH, PROTRUSION OR GATE BURRS  
N IS THE NUMBER OF LEADS

Figure 1

## 6 Testing conditions

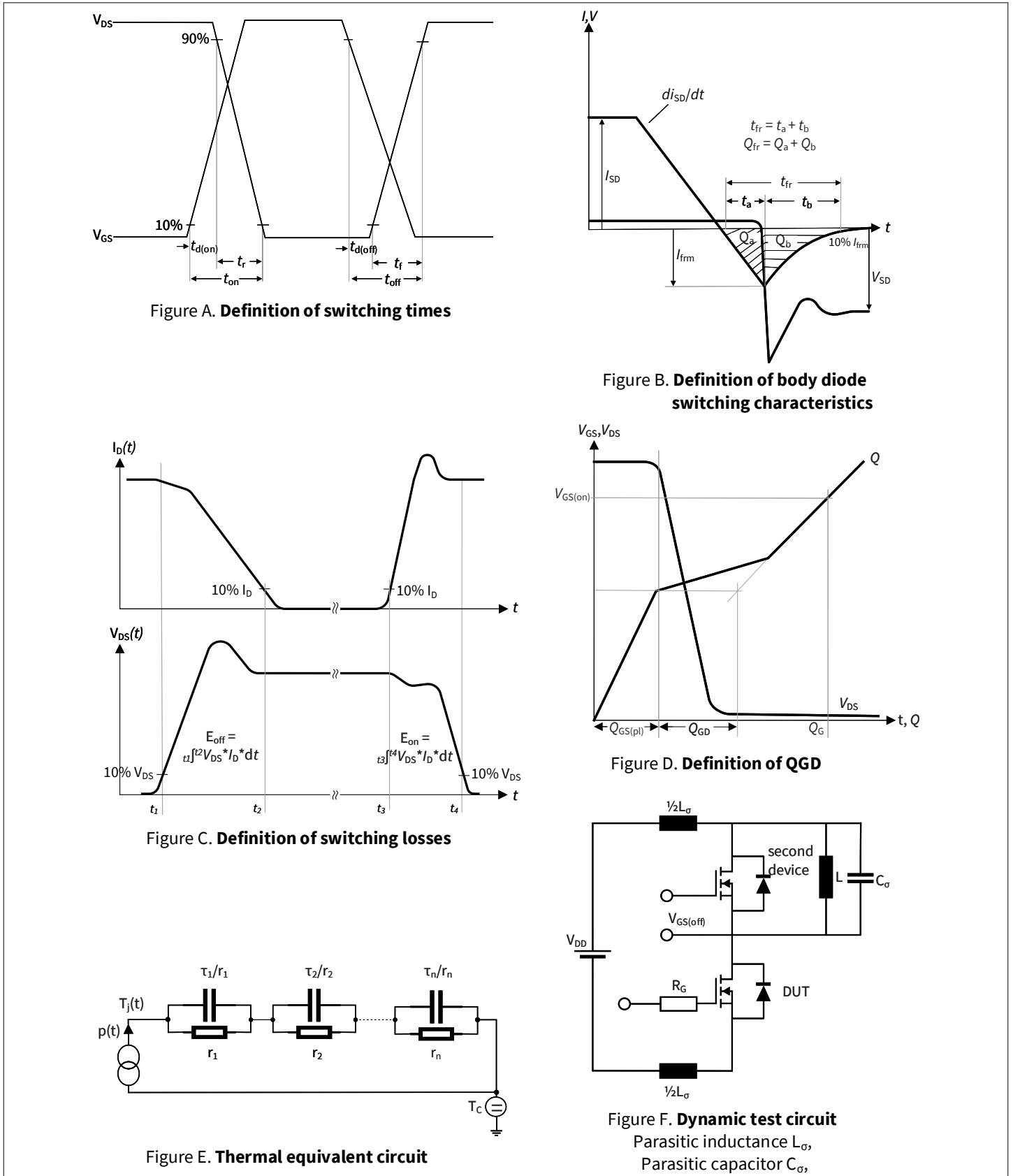


Figure 2

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Revision history

## Revision history

| Document revision | Date of release | Description of changes |
|-------------------|-----------------|------------------------|
| 0.10              | 2024-09-06      | Preliminary datasheet  |
| 1.00              | 2024-09-26      | Final datasheet        |



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